

<b>Notice of References Cited</b>	Application/Control No. 10/693,695	Applicant(s)/Patent Under Reexamination OHSAWA ET AL.
	Examiner Andrew Hwa S. Lee	Art Unit 2877

**U.S. PATENT DOCUMENTS**

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*	E	US-4,684,021	08-1987	Niebling et al.	206/711
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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